Notice of References Cited Application/Control No. 10/562,428 Examiner RYAN OCHYLSKI Applicant(s)/Patent Under Reexamination EGAN, JOSEPH STEVEN Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,192,330	03-1993	Chang et al.	623/23.34
*	В	US-5,718,212	02-1998	Allshouse et al.	124/25.6
*	С	US-5,721,323	02-1998	Schultz et al.	525/504
*	D	US-2001/0049430	12-2001	Winckler et al.	528/271
*	Е	US-2002/0007022	01-2002	OOSEDO et al.	525/527
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	7	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	JP 02153938 A	06-1990	Japan	KOIZUMI et al.	
	0	JP 08008109 A	01-1996	Japan	OKAMOTO et al.	
	Ρ					
	Ø					
	R					
	Ø					
·	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.